

# Search Notes



Application/Control No.

10/827,215

Examiner

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Applicant(s)/Patent under Reexamination

CHEN ET AL.

Art Unit

2144

## SEARCHED

Class	Subclass	Date	Examiner
709	223	12/17	SB
455	456.1-5		
455	419		
370	229		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
(( presence location awareness ) near9 (information data filter restrict\$5 context) )	12/17	SB
(( gateway base (access adj point) ap bsc msc scp ) same (( presence location awareness) adj information)		
(( distribut\$3 local) same (( presence location awareness) adj information) )		
Double Patent Search		
Inventor / Assignee Search		